


<b>Search Notes</b>  	<b>Application/Control No.</b>  10764569	<b>Applicant(s)/Patent Under Reexamination</b>  MOTOYAMA ET AL.
	<b>Examiner</b>  Hoang, Hieu T	<b>Art Unit</b>  2452

SEARCHED			
Class	Subclass	Date	Examiner
709	223, 224	1/15/2008	HH

SEARCH NOTES		
Search Notes	Date	Examiner
EAST	1/15/2008	HH
NPL (Google, IETF)	1/15/2008	HH
Updated EAST	5/27/2009	HH
Consulted with Kenny Lin on allowance	5/19/2009	HH
NPL (Google, IEEE)	5/27/2009	HH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
inteference claim search		5/27/2009	HH

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